











**SN74ALVCH16245** 

SCES015M - JULY 1995-REVISED JUNE 2015

# SN74ALVCH16245 16-Bit Bus Transceiver With 3-State Outputs

#### **Features**

- Member of the Texas Instruments Widebus™
- Operates From 1.65 V to 3.6 V
- Max t<sub>pd</sub> of 3 ns at 3.3 V
- ±24-mA Output Drive at 3.3 V
- Bus Hold on Data Inputs Eliminates the Need for External Pullup or Pulldown Resistors
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)

# **Applications**

- Cable Modem Termination Systems
- Servers
- **LED Displays**
- **Network Switches**
- Telecom Infrastructure
- Motor Drivers
- I/O Expanders

# 3 Description

This 16-bit (dual-octal) noninverting bus transceiver is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

The SN74ALVCH16245 device is designed for asynchronous communication between two data buses. The logic levels of the direction-control (DIR) input and the output-enable (OE) input activate either the B-port outputs or the A-port outputs or place both output ports into the high-impedance mode. The device transmits data from the A bus to the B bus when the B-port outputs are activated, and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports is always active and must have a logic high or low level applied to prevent excess I<sub>CC</sub> and I<sub>CCZ</sub>.

To ensure the high-impedance state during power up or power down,  $\overline{\text{OE}}$  should be tied to  $V_{\text{CC}}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

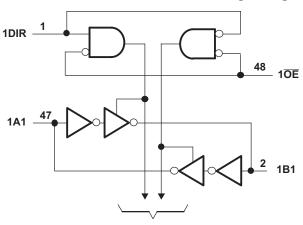
Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

# Device Information<sup>(1)</sup>

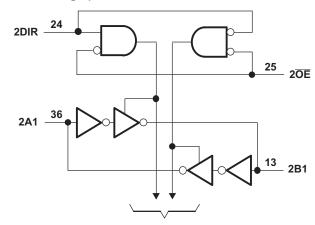
PART NUMBER	PACKAGE	BODY SIZE (NOM)						
SN74ALVCH16245ZRD	BGA MICROSTAR JUNIOR (56)	4.50 mm × 7.00 mm						
SN74ALVCH16245ZQL	BGA MICROSTAR JUNIOR (54)	5.50 mm × 8.00 mm						
SN74ALVCH16245DGG	TSSOP (48)	6.10 mm × 12.50 mm						
SN74ALVCH16245DGV	TVSOP (48)	4.40 mm × 9.70 mm						
SN74ALVCH16245DL	SSOP (48)	7.50 mm × 15.80 mm						

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Logic Diagram (Positive Logic)



To Seven Other Channels



To Seven Other Channels



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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

## Changes from Revision L (November 2005) to Revision M

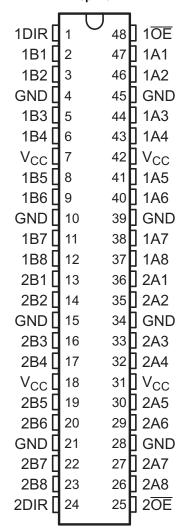
Page

Added ESD Rating table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and 

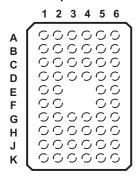


# 5 Pin Configuration and Functions

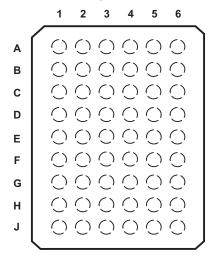
DGG, DGV, or DL Package 48-Pin TSSOP, TVSOP, or SSOP Top View



GQL or ZQL Package 56-Pin BGA MICROSTAR JUNIOR Top View



GRD or ZRD Package 54-Pin BGA MICROSTAR JUNIOR Top View



#### **Pin Functions**

		PIN							
NAME	TSSOP, TVSOP, SSOP	FBGA (56)	FBGA (54)	I/O	DESCRIPTION				
1A1	47	B5	A6	I/O	Transceiver I/O pin				
1A2	46	В6	B5	I/O	Transceiver I/O pin				
1A3	44	C5	В6	I/O	Transceiver I/O pin				
1A4	43	C6	C5	I/O	Transceiver I/O pin				
1A5	41	D5	C6	I/O	Transceiver I/O pin				
1A6	40	D6	D5	I/O	Transceiver I/O pin				
1A7	38	E5	D6	I/O	Transceiver I/O pin				
1A8	37	E6	E5	I/O	Transceiver I/O pin				
2A1	36	F6	E6	I/O	Transceiver I/O pin				
2A2	35	F5	F5	I/O	Transceiver I/O pin				
2A3	33	G6	F6	I/O	Transceiver I/O pin				

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# Pin Functions (continued)

PIN					
NAME	TSSOP, TVSOP, SSOP	FBGA (56)	FBGA (54)	I/O	DESCRIPTION
2A4	32	G5	G5	I/O	Transceiver I/O pin
2A5	30	H6	G6	I/O	Transceiver I/O pin
2A6	29	H5	H5	I/O	Transceiver I/O pin
2A7	27	J6	H6	I/O	Transceiver I/O pin
2A8	26	J5	J6	I/O	Transceiver I/O pin
1DIR	1	A1	А3	Ι	Direction control. When high, the signal propagates from A to B. When low, the signal propagates from B to A.
10E	48	A6	A4	I	Output enable
2DIR	24	K1	J3	I	Direction control. When high, the signal propagates from A to B. When low, the signal propagates from B to A.
20E	25	K6	J4	I	Output enable
1B1	2	B2	A1	I/O	Transceiver I/O pin
1B2	3	B1	B2	I/O	Transceiver I/O pin
1B3	5	C2	B1	I/O	Transceiver I/O pin
1B4	6	C1	C2	I/O	Transceiver I/O pin
1B5	8	D2	C1	I/O	Transceiver I/O pin
1B6	9	D1	D2	I/O	Transceiver I/O pin
1B7	11	E2	D1	I/O	Transceiver I/O pin
1B8	12	E1	E2	I/O	Transceiver I/O pin
2B1	13	F1	E1	I/O	Transceiver I/O pin
2B2	14	F2	F2	I/O	Transceiver I/O pin
2B3	16	G1	F1	I/O	Transceiver I/O pin
B4	17	G2	G2	I/O	Transceiver I/O pin
2B5	19	H1	G1	I/O	Transceiver I/O pin
2B6	20	H2	H2	I/O	Transceiver I/O pin
2B7	22	J1	H1	I/O	Transceiver I/O pin
2B8	23	J2	J1	I/O	Transceiver I/O pin
GND	4,10,15,21,2 8,34,39,45	B3, B4, D3, D4, G3,G4, J3, J4	D3, D4, E3,E4, F3,F4	_	Ground
V <sub>CC</sub>	7,18,31,42	C3,C4,H3, H4,	C3,C4,G3,G4	_	Power pin
NC	_	A2, A3, A4,A5, K2, K3, K4, K5	A2, A5, B3, B4, H3, H4, J2, J5	_	No connect

# Pin Assignments<sup>(1)</sup> (56-Ball GQL or ZQL Package)

		(	0420.2421			
	1	2	3	4	5	6
Α	1DIR	NC	NC	NC	NC	1 <del>OE</del>
В	1B2	1B1	GND	GND	1A1	1A2
С	1B4	1B3	V <sub>CC</sub>	V <sub>CC</sub>	1A3	1A4
D	1B6	1B5	GND	GND	1A5	1A6
E	1B8	1B7			1A7	1A8
F	2B1	2B2			2A2	2A1
G	2B3	2B4	GND	GND	2A4	2A3
Н	2B5	2B6	$V_{CC}$	V <sub>CC</sub>	2A6	2A5
J	2B7	2B8	GND	GND GND 2A8		2A7
K	2DIR	NC	NC	NC	NC	2 <del>OE</del>

(1) NC - No internal connection

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# Pin Assignments <sup>(1)</sup> (54-Ball GRD or ZRD Package)

	1	2	3	4	5	6
Α	1B1	NC	1DIR	1 <del>OE</del>	NC	1A1
В	1B3	1B2	NC	NC	1A2	1A3
С	1B5	1B4	$V_{CC}$	V <sub>CC</sub>	1A4	1A5
D	1B7	1B6	GND	GND	GND 1A6	
E	2B1	1B8	GND	GND	GND 1A8	
F	2B3	2B2	GND	GND	2A2	2A3
G	2B5	2B4	$V_{CC}$	V <sub>CC</sub>	2A4	2A5
Н	2B7	2B6	NC	NC	2A6	2A7
J	2B8	NC	2DIR	2 <del>OE</del>	NC	2A8

<sup>(1)</sup> NC - No internal connection



# 6 Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		-0.5	4.6	V
VI	Input voltage <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
Vo	Output voltage <sup>(2)(3)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		<b>–</b> 50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		<b>–</b> 50	mA
Io	Continuous output current			±50	mA
	Continuous current through each V <sub>CC</sub> or 0	SND		±100	mA
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# 6.2 ESD Ratings

			VALUE	UNIT
	Electrostatic	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	2000	
V <sub>(E</sub>	Electrostatic ESD) discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	1000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

<sup>2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> This value is limited to 4.6 V maximum.



# 6.3 Recommended Operating Conditions

See (1).

			MIN	MAX	UNIT	
V <sub>CC</sub>	Supply voltage		1.65	3.6	V	
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>			
$V_{IH}$	High-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	1.7		V	
		V <sub>CC</sub> = 2.7 V to 3.6 V	2			
		V <sub>CC</sub> = 1.65 V to 1.95 V		0.35 × V <sub>CC</sub>		
$V_{IL}$	Low-level input voltage	$V_{CC}$ = 2.3 V to 2.7 V		0.7	V	
		$V_{CC}$ = 2.7 V to 3.6 V		0.8		
VI	Input voltage		0	V <sub>CC</sub>	V	
Vo	Output voltage		0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 1.65 V		-4		
	High level output ourrent	V <sub>CC</sub> = 2.3 V		-12	m Λ	
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 2.7 V		-12	mA	
		V <sub>CC</sub> = 3 V		-24		
		V <sub>CC</sub> = 1.65 V		4		
	Low lovel output ourrent	V <sub>CC</sub> = 2.3 V		12	<b>~</b> ∧	
l <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mA	
		V <sub>CC</sub> = 3 V		24		
Δt/Δν	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

<sup>(1)</sup> All unused control inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, SCBA004.

# 6.4 Thermal Information<sup>(1)</sup>

				SN74ALVC	H16245		
	THERMAL METRIC <sup>(1)</sup>	DGG (TSSOP) <sup>(2)</sup>	DGV (TVSOP) <sup>(2)</sup>	DL (SSOP) <sup>(2)</sup>	GQL/ZQL (BGA MICROSTAR JUNIOR) <sup>(2)</sup> GRD/ZRD (BGA MICROSTAR JUNIOR) <sup>(2)</sup>		UNIT
		48 PINS	48 PINS	48 PINS	56 PINS	54 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	70	58	63	42	36	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

<sup>(2)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.



#### 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	MIN	TYP <sup>(1)</sup> MAX	UNIT		
	$I_{OH} = -100 \ \mu A$	1.65 V to 3.6 V	V <sub>CC</sub> - 0.2				
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2				
	$I_{OH} = -6 \text{ mA}$	2.3 V	2				
V <sub>OH</sub>		2.3 V	1.7		V		
	$I_{OH} = -12 \text{ mA}$	2.7 V	2.2				
		3 V	2.4				
	$I_{OH} = -24 \text{ mA}$	3 V	2				
	$I_{OL} = 100 \mu A$	1.65 V to 3.6 V		0.2			
	I <sub>OL</sub> = 4 mA	1.65 V		0.45			
V	$I_{OL} = 6 \text{ mA}$	2.3 V		0.4	V		
V <sub>OL</sub>	I <sub>OL</sub> = 12 mA	2.3 V		0.7	]		
	IOL = 12 IIIA	2.7 V		0.4			
	I <sub>OL</sub> = 24 mA	3 V		0.55			
I <sub>I</sub>	$V_I = V_{CC}$ or GND	3.6 V		±5	μΑ		
	V <sub>I</sub> = 0.58 V	1.65 V	25				
	V <sub>I</sub> = 1.07 V	1.65 V	-25				
	V <sub>I</sub> = 0.7 V	2.3 V	45				
I <sub>I(hold)</sub>	V <sub>I</sub> = 1.7 V	2.3 V	-45		μΑ		
	V <sub>I</sub> = 0.8 V	3 V	75				
	V <sub>I</sub> = 2 V	3 V	-75				
	$V_1 = 0 \text{ to } 3.6 \text{ V}^{(2)}$	3.6 V		±500			
I <sub>OZ</sub> <sup>(3)</sup>	$V_O = V_{CC}$ or GND	3.6 V		±10	μΑ		
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V		40	μΑ		
ΔI <sub>CC</sub>	One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 3.6 V		750	μA		
C <sub>i</sub> Control inputs	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		4	pF		
C <sub>io</sub> A or B ports	$V_O = V_{CC}$ or GND	3.3 V		8	pF		

# 6.6 Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 7)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = ± 0.2		V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 0.3	3.3 V 3 V	UNIT
	(INPUT)	(OUTPUT)	TYP	MIN	MAX	MIN	MAX	MIN	MAX	
$t_{pd}$	A or B	B or A	See <sup>(1)</sup>	1	3.7		3.6	1	3	ns
t <sub>en</sub>	ŌĒ	A or B	See <sup>(1)</sup>	1	5.7		5.4	1	4.4	ns
t <sub>dis</sub>	ŌĒ	A or B	See <sup>(1)</sup>	1	5.2		4.6	1	4.1	ns

<sup>(1)</sup> This information was not available at the time of publication.

# 6.7 Operating Characteristics

 $T_A = 25^{\circ}C$ 

PARAMETER			TEST C	ONDITIONS	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	$V_{CC}$ = 3.3 V	UNIT
FARAMETER		1231 00	JADITIONS	TYP	TYP	TYP TYP		
0	Power dissipation	Outputs enabled	C	f 40 MH=	See <sup>(1)</sup>	22	29	,
C <sub>pd</sub>	capacitance	Outputs disabled	$C_L = 50 \text{ pF},$	f = 10 MHz	See <sup>(1)</sup>	4	5	pF

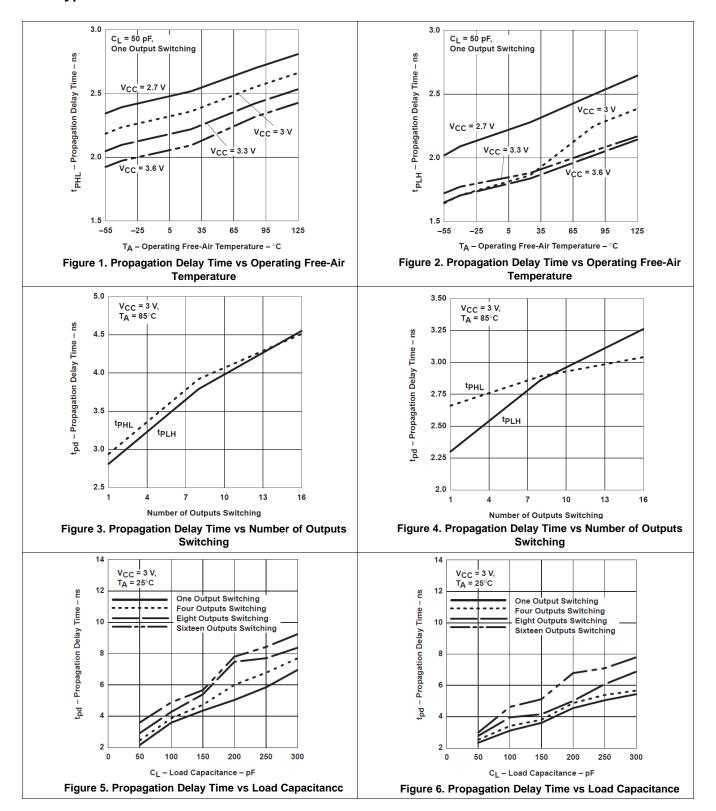
(1) This information was not available at the time of publication.

<sup>(1)</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ . (2) This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to

For I/O ports, the parameter  $I_{\text{OZ}}$  includes the input leakage current.

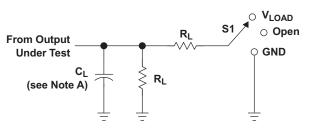


# 6.8 Typical Characteristics





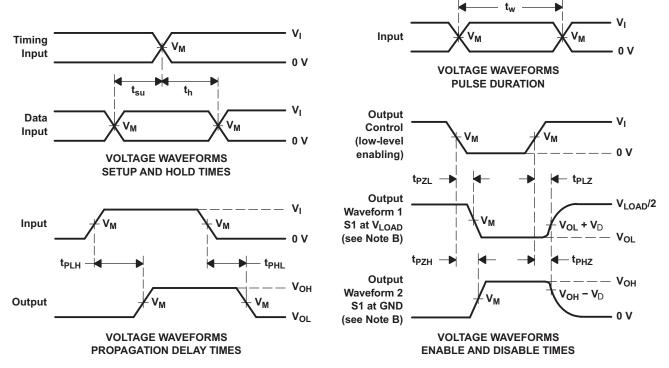
### 7 Parameter Measurement Information



TEST	<b>S</b> 1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub> t <sub>PHZ</sub> /t <sub>PZH</sub>	V <sub>LOAD</sub> GND

**LOAD CIRCUIT** 

	INPUT		,,	\ \ \		-	\ \ \	
V <sub>CC</sub>	V <sub>I</sub> t <sub>r</sub> /t <sub>f</sub>		V <sub>M</sub>	V <sub>LOAD</sub>	CL	$R_L$	<b>V</b> <sub>D</sub>	
1.8 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2 × V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V	
2.5 V ± 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2 × V <sub>CC</sub>	30 pF	<b>500</b> Ω	0.15 V	
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	
3.3 V ± 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V	



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR≤ 10 MHz, Z<sub>O</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 7. Load Circuit and Voltage Waveforms

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# 8 Detailed Description

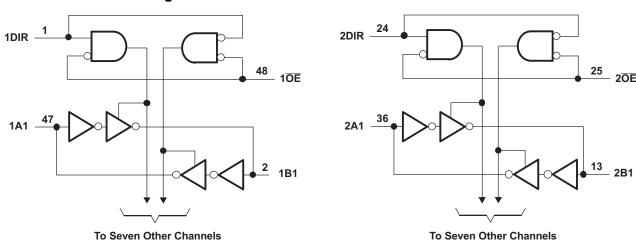
#### 8.1 Overview

The SN74ALVCH16245 device is designed for asynchronous communication between two data buses. The logic levels of the direction-control (DIR) input and the output-enable  $(\overline{OE})$  input activate either the B-port outputs or the A-port outputs or place both output ports into the high-impedance mode. The device transmits data from the A bus to the B bus when the B-port outputs are activated, and from the B bus to the A bus when the A-port outputs are activated. The input circuitry on both A and B ports is always active and must have a logic high or low level applied to prevent excess  $I_{CC}$  and  $I_{CCZ}$ .

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

#### 8.2 Functional Block Diagrams



#### 8.3 Feature Description

The input tolerance of 5.5V inputs allows the device to be used in down voltage translation applications as well for example if translation is required from 5 V to 3.3 V or 1.8 V. Also bus hold on data inputs eliminates the need for external pullup or pulldown resistors to be used, enabling customer to save board space and system cost.

## 8.4 Device Functional Modes

Table 1 lists the functional modes for SN74ALVCH16245.

**Table 1. Function Table** 

INP	UTS	OPERATION
ŌĒ	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	X	Isolation

Product Folder Links: SN74ALVCH16245



# 9 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 9.1 Application Information

SN74ALVCH16245A is a high-drive CMOS device that can be used for a multitude of bus interface type applications where output drive or PCB trace length is a concern. The inputs can accept voltages to 5.5 V at any valid  $V_{CC}$  making it ideal for down translation.

# 9.2 Typical Application

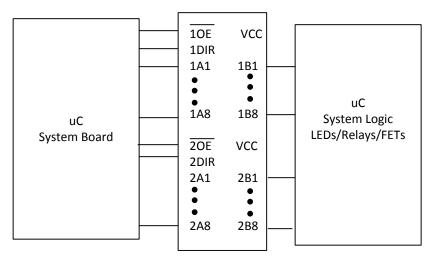


Figure 8. Typical Application Schematic

#### 9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so routing and load conditions should be considered to prevent ringing.

#### 9.2.2 Detailed Design Procedure

- 1. Recommended Input Conditions
  - For rise time and fall time specification, see Switching Characteristics
  - For specified high and low levels, see (V<sub>IH</sub> and V<sub>IL</sub>) in the *Electrical Characteristics* table.
  - Inputs are overvoltage tolerant allowing them to go as high as (V<sub>I</sub> max) in the Absolute Maximum Ratings
    table at any valid V<sub>CC</sub>.

## 2. Recommend Output Conditions

- Load currents should not exceed (I<sub>O</sub> max) per output and should not exceed (Continuous current through V<sub>CC</sub> or GND) total current for the part. These limits are located in the *Recommended Operating* Conditions table.
- Outputs should not be pulled above V<sub>CC</sub>.

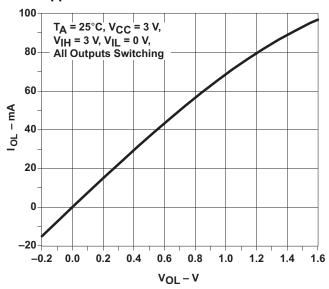
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### Typical Application (continued)

#### 9.2.3 Application Curves



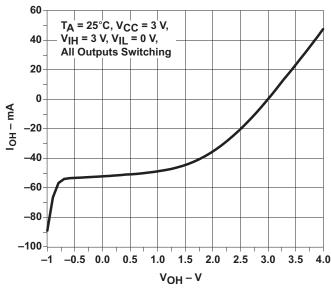


Figure 9. Output Drive Current (I<sub>OL</sub>) vs LOW-level Output Voltage (V<sub>OL</sub>)

Figure 10. Output Drive Current (I<sub>OH</sub>) vs HIGH-level Output Voltage (V<sub>OH</sub>)

# 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Absolute Maximum Ratings* table.

Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single-supply, a 0.1- $\mu$ F capacitor is recommended. If there are multiple  $V_{CC}$  terminals then 0.01- $\mu$ F or 0.022- $\mu$ F capacitors are recommended for each power terminal. It is ok to parallel multiple bypass capacitors to reject different frequencies of noise. Multiple bypass capacitors may be paralleled to reject different frequencies of noise. The bypass capacitor should be installed as close to the power terminal as possible for the best results.

# 11 Layout

#### 11.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states.

Specified in Figure 11 are rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or  $V_{CC}$ , whichever makes more sense or is more convenient.

#### 11.2 Layout Example



Figure 11. Layout Diagram



# 12 Device and Documentation Support

#### 12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.2 Trademarks

Widebus, E2E are trademarks of Texas Instruments.

All other trademarks are the property of their respective owners.

### 12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# 12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 10-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/			Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
74ALVCH16245DGGRG4	Active	Production	TSSOP (DGG)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
74ALVCH16245DGVRG4	Active	Production	TVSOP (DGV)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VH245
74ALVCH16245DGVRG4.B	Active	Production	TVSOP (DGV)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VH245
SN74ALVCH16245DGGR	Active	Production	TSSOP (DGG)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
SN74ALVCH16245DGGR.B	Active	Production	TSSOP (DGG)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
SN74ALVCH16245DGVR	Active	Production	TVSOP (DGV)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VH245
SN74ALVCH16245DGVR.B	Active	Production	TVSOP (DGV)   48	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	VH245
SN74ALVCH16245DL	Active	Production	SSOP (DL)   48	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
SN74ALVCH16245DL.B	Active	Production	SSOP (DL)   48	25   TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
SN74ALVCH16245DLR	Active	Production	SSOP (DL)   48	1000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245
SN74ALVCH16245DLR.B	Active	Production	SSOP (DL)   48	1000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ALVCH16245

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE OPTION ADDENDUM**

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN74ALVCH16245:

Enhanced Product : SN74ALVCH16245-EP

NOTE: Qualified Version Definitions:

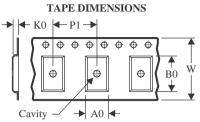
• Enhanced Product - Supports Defense, Aerospace and Medical Applications

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

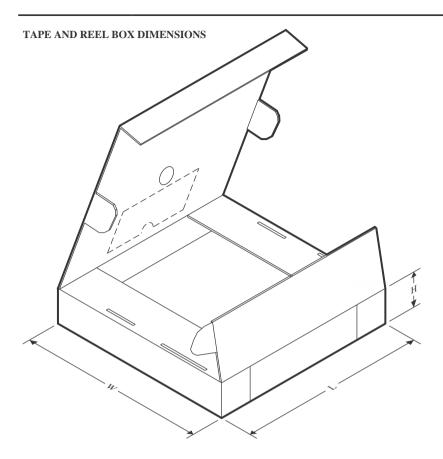
#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74ALVCH16245DGVRG4	TVSOP	DGV	48	2000	330.0	16.4	7.1	10.2	1.6	12.0	16.0	Q1
SN74ALVCH16245DGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1
SN74ALVCH16245DGVR	TVSOP	DGV	48	2000	330.0	16.4	7.1	10.2	1.6	12.0	16.0	Q1
SN74ALVCH16245DLR	SSOP	DL	48	1000	330.0	32.4	11.35	16.2	3.1	16.0	32.0	Q1

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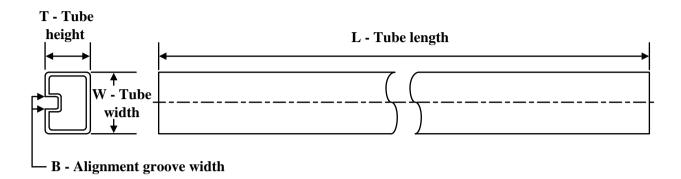
#### \*All dimensions are nominal

Device	Package Type	ackage Type Package Drawing		SPQ	Length (mm)	Width (mm)	Height (mm)		
74ALVCH16245DGVRG4	TVSOP	DGV	48	2000	353.0	353.0	32.0		
SN74ALVCH16245DGGR	TSSOP	DGG	48	2000	356.0	356.0	45.0		
SN74ALVCH16245DGVR	TVSOP	DGV	48	2000	353.0	353.0	32.0		
SN74ALVCH16245DLR	SSOP	DL	48	1000	356.0	356.0	53.0		

# **PACKAGE MATERIALS INFORMATION**

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# **TUBE**

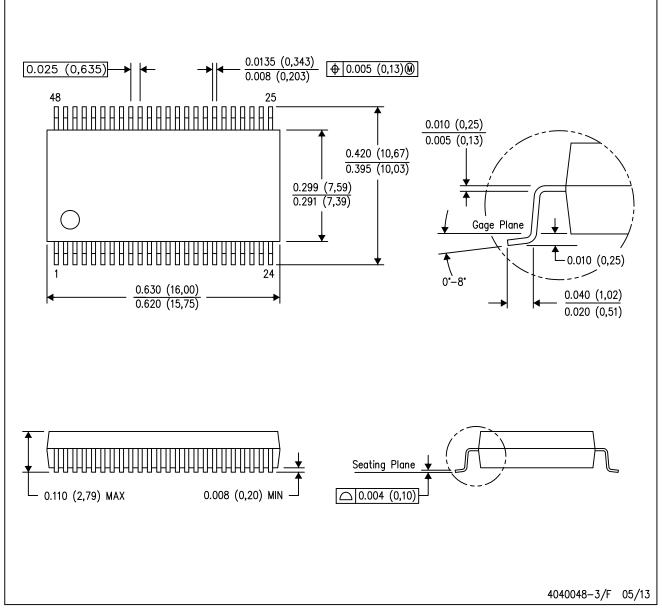


#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74ALVCH16245DL	DL	SSOP	48	25	473.7	14.24	5110	7.87
SN74ALVCH16245DL.B	DL	SSOP	48	25	473.7	14.24	5110	7.87

# DL (R-PDSO-G48)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MO-118

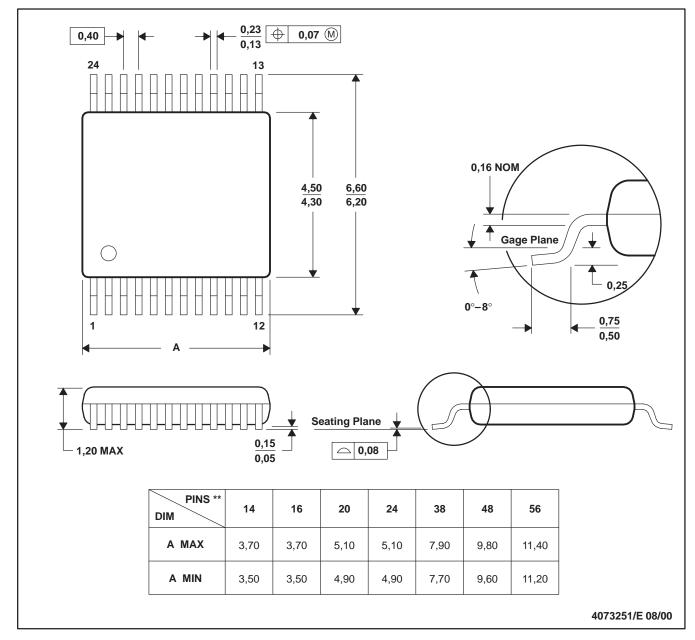
PowerPAD is a trademark of Texas Instruments.



# DGV (R-PDSO-G\*\*)

# 24 PINS SHOWN

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

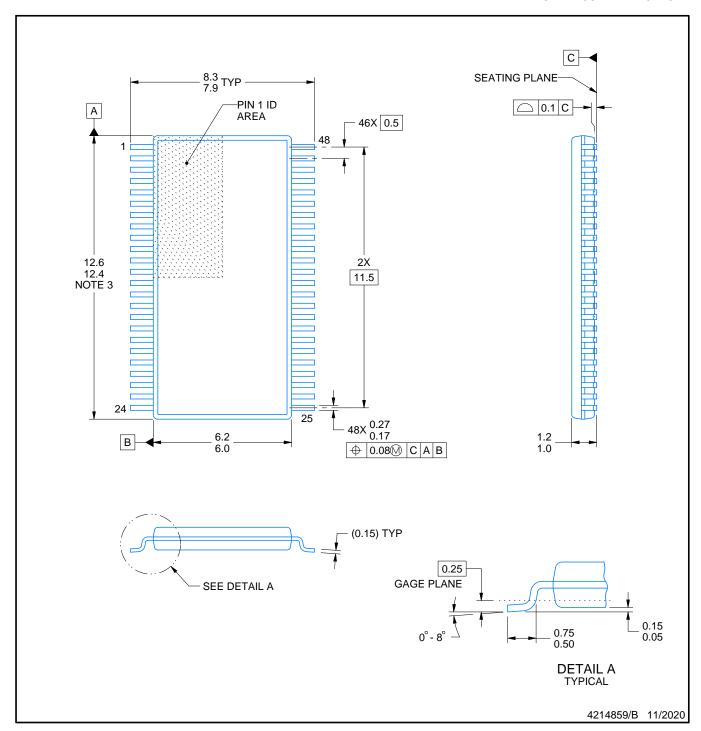
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



SMALL OUTLINE PACKAGE



## NOTES:

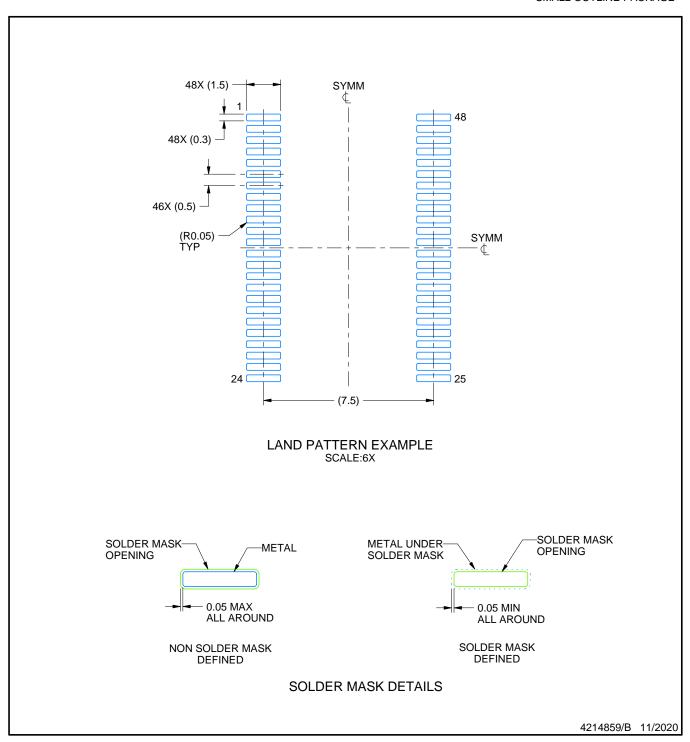
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE

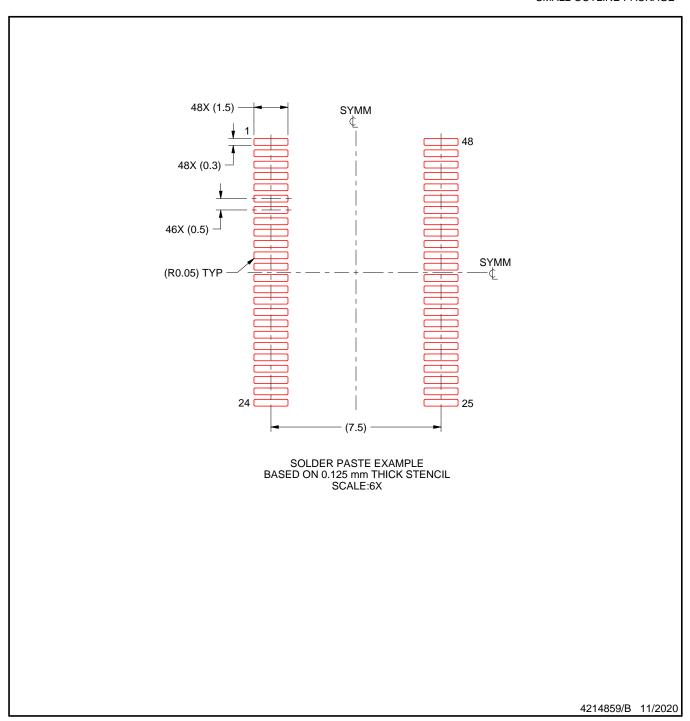


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

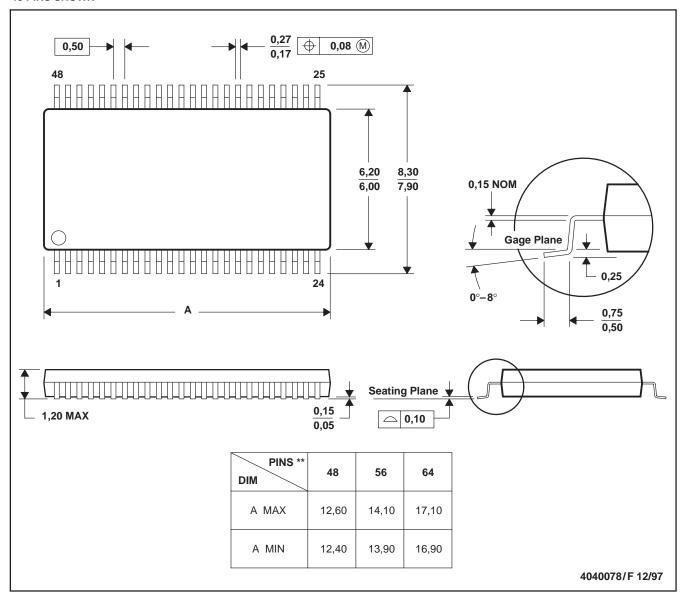
- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



# DGG (R-PDSO-G\*\*)

# PLASTIC SMALL-OUTLINE PACKAGE

#### **48 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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